Product data sheet

1. General description

The 74LVC594A is an 8-bit serial-in/serial or parallel-out shift register with a storage register. Separate clock and reset inputs are provided on both shift and storage registers. The device features a serial input (DS) and a serial output (Q7S) to enable cascading. Data is shifted on the LOW-to-HIGH transitions of the SHCP input, and the data in the shift register is transferred to the storage register on a LOW-to-HIGH transition of the STCP input. If both clocks are connected together, the shift register will always be one clock pulse ahead of the storage register. A LOW level on one of the two register reset pins ($\overline{\rm SHR}$ and $\overline{\rm STR}$) will clear the corresponding register. Inputs can be driven from either 3.3 V or 5 V devices. This feature allows the use of these devices as translators in mixed 3.3 V and 5 V environments.

Schmitt-trigger action at all inputs makes the circuit tolerant of slower input rise and fall times.

This device is fully specified for partial power down applications using I_{OFF} . The I_{OFF} circuitry disables the output, preventing the potentially damaging backflow current through the device when it is powered down.

2. Features and benefits

- Overvoltage tolerant inputs to 5.5 V
- Wide supply voltage range from 1.2 V to 3.6 V
- · CMOS low power dissipation
- · Direct interface with TTL levels
- I_{OFF} circuitry provides partial Power-down mode operation
- · Balanced propagation delays
- All inputs have Schmitt-trigger action
- Complies with JEDEC standard:
 - JESD8-7A (1.65 V to 1.95 V)
 - JESD8-5A (2.3 V to 2.7 V)
 - JESD8-C/JESD36 (2.7 V to 3.6 V)
- ESD protection:
 - HBM: ANSI/ESDA/JEDEC JS-001 class 2 exceeds 2000 V
 - CDM: ANSI/ESDA/JEDEC JS-002 class C3 exceeds 1000 V
- Specified from -40 °C to +85 °C and -40 °C to +125 °C

3. Applications

- Serial-to-parallel data conversion
- Remote control holding register



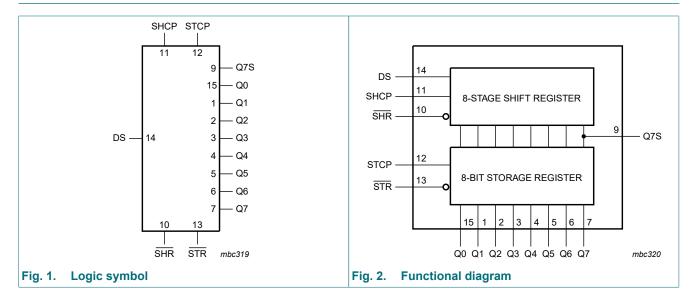
8-bit shift register with output register

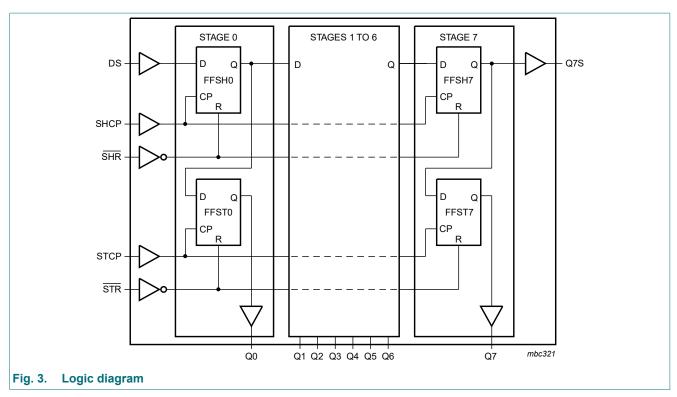
4. Ordering information

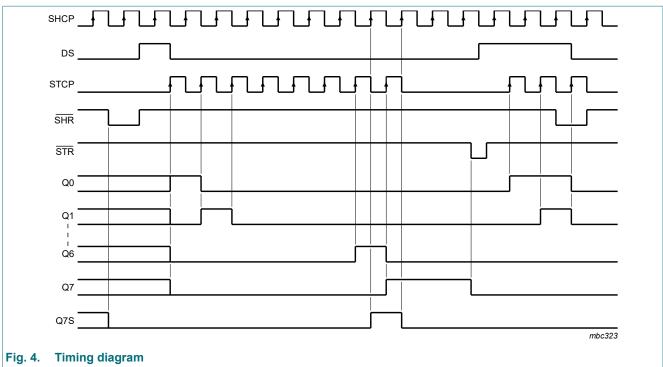
Table 1. Ordering information

Type number	Package	Package							
	Temperature range Name		Description	Version					
74LVC594AD	-40 °C to +125 °C	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1					
74LVC594APW	-40 °C to +125 °C	TSSOP16	plastic thin shrink small outline package; 16 leads; body width 4.4 mm	SOT403-1					
74LVC594ABQ	-40 °C to +125 °C	DHVQFN16	plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 16 terminals; body 2.5 × 3.5 × 0.85 mm	SOT763-1					
74LVC594ABZ	-40 °C to +125 °C	DHXQFN16	plastic, leadless dual in-line compatible thermal enhanced extreme thin quad flat package; no leads; 16 terminals; 0.4 mm pitch; body 2 mm × 2.4 mm × 0.48 mm	SOT8016-1					

5. Functional diagram



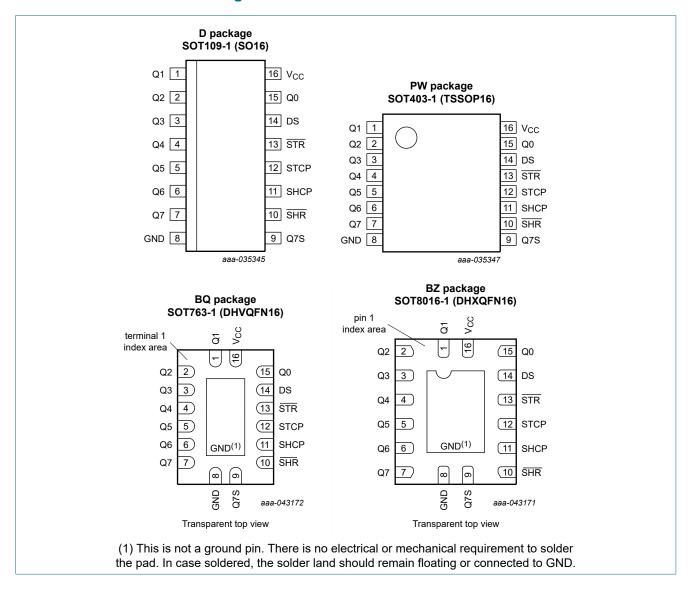




8-bit shift register with output register

6. Pinning information

6.1. Pinning



8-bit shift register with output register

6.2. Pin description

Table 2. Pin description

Symbol	Pin	Description
Q0, Q1, Q2, Q3, Q4, Q5, Q6, Q7	15, 1, 2, 3, 4, 5, 6, 7	parallel data output
GND	8	ground (0 V)
Q7S	9	serial data output
SHR	10	shift register reset (active LOW)
SHCP	11	shift register clock input
STCP	12	storage register clock input
STR	13	storage register reset (active LOW)
DS	14	serial data input
V _{CC}	16	supply voltage

7. Functional description

Table 3. Function table

 $H = HIGH \ voltage \ state; \ L = LOW \ voltage \ state; \ \uparrow = LOW-to-HIGH \ transition; \ X = don't \ care; \ NC = no \ change$

Input					Output		Function
SHCP	STCP	SHR	STR	DS	Q7S	Qn	
X	Х	L	Х	Х	L	NC	a LOW-state on SHR only affects the shift register
X	Х	Х	L	Х	NC	L	a LOW-state on STR only affects the storage register
X	1	L	Н	Х	L	L	empty shift register loaded into storage register
1	X	Н	Х	Н	Q6S	NC	logic HIGH level shifted into shift register stage 0. Contents of all shift register stages shifted through, e.g. previous state of stage 6 (internal Q6S) appears on the serial output (Q7S)
X	1	Н	Н	Х	NC	QnS	contents of shift register stages (internal QnS) are transferred to the storage register and parallel output stages
↑	↑	Н	Н	Х	Q6S	QnS	contents of shift register shifted through; previous contents of the shift register is transferred to the storage register and the parallel output stages

8. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage		-0.5	+6.5	V
I _{IK}	input clamping current	V _I < 0 V	-50	-	mA
VI	input voltage	[1]	-0.5	+6.5	V
I _{OK}	output clamping current	$V_O > V_{CC}$ or $V_O < 0$ V	-	±50	mA
Vo	output voltage	3-state [1]	-0.5	6.5	V
		output HIGH or LOW state [1]	-0.5	V _{CC} + 0.5	V
Io	output current	$V_O = 0 \text{ V to } V_{CC}$	-	±50	mA
I _{CC}	supply current		-	100	mA
I _{GND}	ground current		-100	-	mA

8-bit shift register with output register

Symbol	Parameter	Conditions	Min	Max	Unit
T _{stg}	storage temperature		-65	+150	°C
P _{tot}	total power dissipation	T _{amb} = -40 °C to +125 °C			
		SOT109-1 (SO16) [2] SOT403-1 (TSSOP16) [3] SOT763-1 (DHVQFN16) [4]	-	500	mW
		SOT8016-1 (DHXQFN16)	-	250	mW

- The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
- For SOT109-1 (SO16) package: P_{tot} derates linearly with 12.4 mW/K above 110 °C.
- [3]
- For SOT403-1 (TSSOP16) package: P_{tot} derates linearly with 8.5 mW/K above 91 °C. For SOT763-1 (DHVQFN16) package: P_{tot} derates linearly with 11.2 mW/K above 106 °C.

9. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CC}	supply voltage		1.65	-	3.6	V
		functional	1.2	-	-	V
VI	input voltage		0	-	5.5	V
Vo	output voltage	3-state	0	-	5.5	V
		output HIGH or LOW state	0	-	V _{CC}	V
T _{amb}	ambient temperature		-40	-	+125	°C
Δt/ΔV	input transition rise and fall rate	V _{CC} = 1.65 V to 2.7 V	-	-	20	ns/V
		V _{CC} = 2.7 V to 3.6 V	-	-	10	ns/V

10. Static characteristics

Table 6. Static characteristics

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	-40	°C to +8	5 °C	-40 °C to	+125 °C	Unit
			Min	Typ[1]	Max	Min	Max	
V _{IH}	HIGH-level input	V _{CC} = 1.2 V	1.08	-	-	1.08	-	V
	voltage	V _{CC} = 1.65 V to 1.95 V	0.65V _{CC}	-	-	0.65V _{CC}	-	V
		V _{CC} = 2.3 V to 2.7 V	1.7	-	-	1.7	-	V
		V _{CC} = 2.7 V to 3.6 V	2.0	-	-	2.0	-	V
V _{IL}	LOW-level input	V _{CC} = 1.2 V	-	-	0.12	-	0.12	V
	voltage	V _{CC} = 1.65 V to 1.95 V	-	-	0.35V _{CC}	-	0.35V _{CC}	V
		V _{CC} = 2.3 V to 2.7 V	-	-	0.7	-	0.7	V
		V _{CC} = 2.7 V to 3.6 V	-	-	0.8	-	0.8	V
V _{OH}	HIGH-level output	V _I = V _{IH} or V _{IL}						
	voltage	I _O = -100 μA; V _{CC} = 1.65 V to 3.6 V	V _{CC} -0.2	-	-	V _{CC} -0.3	-	V
		I _O = -4 mA; V _{CC} = 1.65 V	1.2	-	-	1.05	-	V
		I _O = -8 mA; V _{CC} = 2.3 V	1.8	-	-	1.65	-	V
		I _O = -12 mA; V _{CC} = 2.7 V	2.2	-	-	2.05	-	V
		I _O = -18 mA; V _{CC} = 3.0 V	2.4	-	-	2.25	-	V
		I _O = -24 mA; V _{CC} = 3.0 V	2.2	-	-	2.0	-	V

8-bit shift register with output register

Symbol	Parameter	Conditions	-40	°C to +8	5 °C	-40 °C to	+125 °C	Unit
			Min	Typ[1]	Max	Min	Max	
V _{OL}	LOW-level output	V _I = V _{IH} or V _{IL}						
	voltage	I _O = 100 μA; V _{CC} = 1.65 V to 3.6 V	-	-	0.2	-	0.3	V
		I _O = 4 mA; V _{CC} = 1.65 V	-	-	0.45	-	0.65	V
		$I_O = 8 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	-	0.6	-	0.8	V
		I _O = 12 mA; V _{CC} = 2.7 V	-	-	0.4	-	0.6	V
		I_{O} = 24 mA; V_{CC} = 3.0 V	-	-	0.55	-	0.8	V
l _l	input leakage current	$V_{CC} = 3.6 \text{ V}; V_I = 5.5 \text{ V or GND}$	-	±0.1	±5	-	±20	μΑ
I _{OFF}	power-off leakage current	$V_{CC} = 0 \text{ V}; V_{I} \text{ or } V_{O} = 5.5 \text{ V}$	-	0.1	10	-	20	μΑ
Icc	supply current	V _{CC} = 3.6 V; V _I = V _{CC} or GND; I _O = 0 A	-	0.1	10	-	40	μΑ
ΔI _{CC}	additional supply current	per input pin; V _{CC} = 1.65 V to 3.6 V; V _I = V _{CC} - 0.6 V; I _O = 0 A	-	5	500	-	5000	μΑ
Cı	input capacitance	V_{CC} = 0 V to 3.6 V; V_{I} = GND to V_{CC}	-	5.0	-	-	-	pF

^[1] All typical values are measured at V_{CC} = 3.3 V (unless stated otherwise) and T_{amb} = 25 °C.

11. Dynamic characteristics

Table 7. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V). For test circuit see Fig. 11.

Symbol	Parameter	Conditions	-40 °C to +85 °C		-40 °C to +125 °C		Unit	
			Min	Typ[1]	Max	Min	Max	
t _{pd}	propagation delay	SHCP to Q7S; see Fig. 5 [2] [3]						
		V _{CC} = 1.2 V	-	17.5	-	-	-	ns
		V _{CC} = 1.65 V to 1.95 V	2.0	5.2	15.8	2.0	18.2	ns
		V _{CC} = 2.3 V to 2.7 V	1.5	3.2	8.1	1.5	9.3	ns
		V _{CC} = 2.7 V	1.5	3.5	7.6	1.5	8.7	ns
		V _{CC} = 3.0 V to 3.6 V	1.5	3.1	6.7	1.5	7.7	ns
		STCP to Qn; see Fig. 6 [2]						
		V _{CC} = 1.2 V	-	19.3	-	-	-	ns
		V _{CC} = 1.65 V to 1.95 V	2.0	7.6	15.8	2.0	18.2	ns
		V _{CC} = 2.3 V to 2.7 V	1.5	4.8	8.1	1.5	9.3	ns
		V _{CC} = 2.7 V	1.5	5.2	7.6	1.5	8.7	ns
		V _{CC} = 3.0 V to 3.6 V	1.2	4.5	6.7	1.2	7.7	ns

Symbol	Parameter	Conditions	-40	°C to +85	5 °C	-40 °C to	Unit	
			Min	Typ[1]	Max	Min	Max	
t _{PHL}	HIGH to LOW	SHR to Q7S; see Fig. 9						
	propagation delay	V _{CC} = 1.2 V	-	12.0	-	-	-	ns
		V _{CC} = 1.65 V to 1.95 V	2.0	5.0	15.8	2.0	18.2	ns
		V _{CC} = 2.3 V to 2.7 V	1.5	3.8	8.1	1.5	9.3	ns
		V _{CC} = 2.7 V	1.2	3.9	7.6	1.2	8.7	ns
		V _{CC} = 3.0 V to 3.6 V	1.2	3.3	6.7	1.2	7.7	ns
		STR to Qn; see Fig. 10						
		V _{CC} = 1.2 V	-	20.0	-	-	-	ns
		V _{CC} = 1.65 V to 1.95 V	2.0	7.7	15.8	2.0	18.2	ns
		V _{CC} = 2.3 V to 2.7 V	1.5	5.0	8.1	1.5	9.3	ns
		V _{CC} = 2.7 V	1.2	5.3	7.6	1.2	8.7	ns
		V _{CC} = 3.0 V to 3.6 V	1.2	4.4	6.7	1.2	7.7	ns
t _W	pulse width	SHCP, STCP HIGH or LOW; see Fig. 5 and Fig. 6						
		V _{CC} = 1.65 V to 1.95 V	6.0	2.5	-	7.0	-	ns
		V _{CC} = 2.3 V to 2.7 V	5.0	2.0	-	5.5	-	ns
		V _{CC} = 2.7 V	4.5	1.5	-	5.0	-	ns
		V _{CC} = 3.0 V to 3.6 V	4.0	1.5	-	4.5	-	ns
		SHR, STR LOW; see Fig. 9 and Fig. 10						
		V _{CC} = 1.65 V to 1.95 V	6.0	2.5	-	5.5	-	ns
		V _{CC} = 2.3 V to 2.7 V	4.0	2.0	-	4.5	-	ns
		V _{CC} = 2.7 V	2.5	1.5	-	3.0	-	ns
		V _{CC} = 3.0 V to 3.6 V	2.5	1.5	-	3.0	-	ns
t _{su}	set-up time	DS to SHCP; see Fig. 7						
		V _{CC} = 1.65 V to 1.95 V	5.0	1.0	-	5.5	-	ns
		V _{CC} = 2.3 V to 2.7 V	4.0	0.8	-	4.5	-	ns
		V _{CC} = 2.7 V	2.0	0.6	-	2.5	-	ns
		V _{CC} = 3.0 V to 3.6 V	2.0	0.6	-	2.5	-	ns
		SHR to STCP; see Fig. 8						
		V _{CC} = 1.65 V to 1.95 V	8.0	3.5	-	8.5	-	ns
		V _{CC} = 2.3 V to 2.7 V	5.0	2.1	-	5.5	-	ns
		V _{CC} = 2.7 V	4.0	1.8	-	4.5	-	ns
		V _{CC} = 3.0 V to 3.6 V	4.0	1.7	-	4.5	-	ns
		SHCP to STCP; see Fig. 6						1
		V _{CC} = 1.65 V to 1.95 V	8.0	3.5	-	8.5	-	ns
		V _{CC} = 2.3 V to 2.7 V	5.0	2.1	-	5.5	-	ns
		V _{CC} = 2.7 V	4.0	1.8	-	4.5	-	ns
		V _{CC} = 3.0 V to 3.6 V	4.0	1.7	-	4.5	-	ns

8-bit shift register with output register

Symbol	Parameter	Conditions	-40	°C to +85	5 °C	-40 °C to	+125 °C	Unit
			Min	Typ[1]	Max	Min	Max	
t _h	hold time	DS to SHCP; see Fig. 7 [3]						
		V _{CC} = 1.65 V to 1.95 V	1.5	0.2	-	2.0	-	ns
		V _{CC} = 2.3 V to 2.7 V	1.5	0.1	-	2.0	-	ns
		V _{CC} = 2.7 V	1.5	-0.1	-	2.0	-	ns
		V _{CC} = 3.0 V to 3.6 V	1.0	-0.2	-	1.5	-	ns
t _{rec} rec	recovery time	SHR to SHCP, STR to STCP; see Fig. 9 and Fig. 10						
		V _{CC} = 1.65 V to 1.95 V	5.0	-2.7	-	5.5	-	ns
		V _{CC} = 2.3 V to 2.7 V	4.0	-1.5	-	4.5	-	ns
		V _{CC} = 2.7 V	2.0	-1.0	-	2.5	-	ns
		V _{CC} = 3.0 V to 3.6 V	2.0	-1.0	-	2.5	-	ns
f _{max}	maximum frequency	SHCP or STCP; see Fig. 5 and Fig. 6						
		V _{CC} = 1.65 V to 1.95 V	80	130	-	70	-	MHz
		V _{CC} = 2.3 V to 2.7 V	100	140	-	90	-	MHz
		V _{CC} = 2.7 V	110	150	-	100	-	MHz
		V _{CC} = 3.0 V to 3.6 V	130	180	-	115	-	MHz
t _{sk(o)}	output skew time	V _{CC} = 3.0 V to 3.6 V [4]	-	-	1.0	-	1.5	ns
C _{PD}	power dissipation	$V_I = GND \text{ to } V_{CC}$ [5]						
	capacitance	V _{CC} = 1.65 V to 1.95 V	-	50	-	-	-	pF
		V _{CC} = 2.3 V to 2.7 V	-	45	-	-	-	pF
		V _{CC} = 3.0 V to 3.6 V	-	44	-	-	-	pF

- Typical values are measured at T_{amb} = 25 °C and V_{CC} = 1.8 V, 2.5 V, 2.7 V, and 3.3 V respectively.
- [2] [3]
- t_{pd} is the same as t_{PLH} and t_{PHL} . Cascadability is guaranteed under identical V_{CC} and temperature conditions.
- Skew between any two outputs of the same package switching in the same direction. This parameter is guaranteed by design. C_{PD} is used to determine the dynamic power dissipation (P_D in μ W). $P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \sum (C_L \times V_{CC}^2 \times f_o)$ where: [4]

 f_i = input frequency in MHz;

fo = output frequency in MHz;

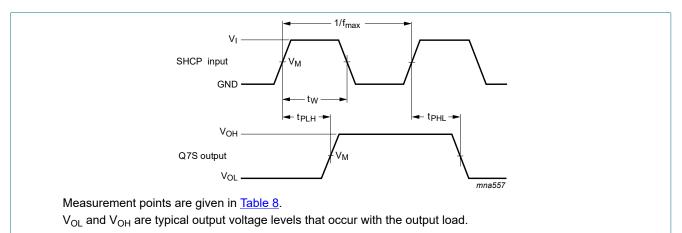
C_L = output load capacitance in pF;

V_{CC} = supply voltage in V;

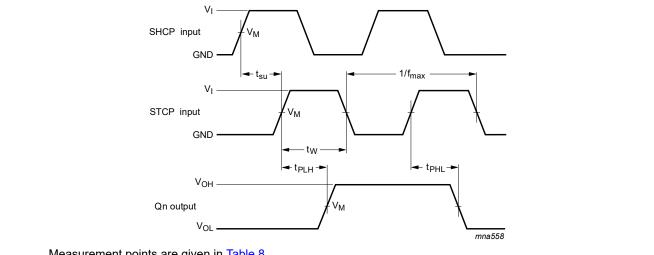
N = number of inputs switching; $\sum (C_L \times V_{CC}^2 \times f_0) = \text{sum of outputs.}$

8-bit shift register with output register

11.1. Waveforms and test circuit



The shift clock (SHCP) to serial data output (Q7S) propagation delays, the shift clock pulse width and Fig. 5. maximum shift clock frequency

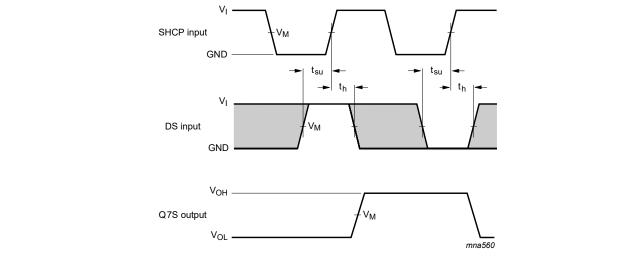


Measurement points are given in Table 8.

 V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

Fig. 6. The storage clock (STCP) to parallel data output (Qn) propagation delays, the storage clock pulse width and the shift clock to storage clock set-up time

8-bit shift register with output register

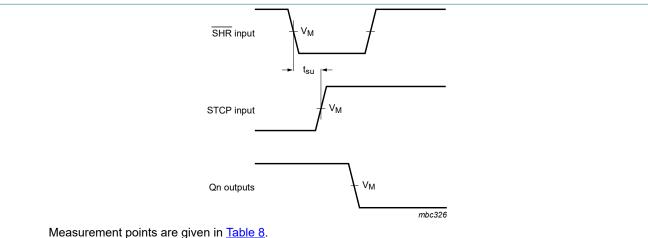


Measurement points are given in Table 8.

The shaded areas indicate when the input is permitted to change for predictable output performance.

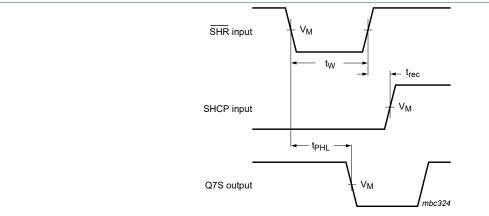
V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

The data set-up and hold times for the serial data input (DS) Fig. 7.



V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

The shift reset (SHR) to storage clock (STCP) set-up times Fig. 8.

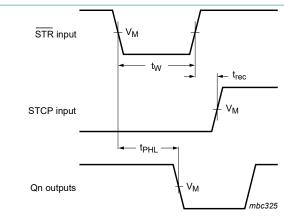


Measurement points are given in Table 8.

V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

The shift reset (SHR) pulse width, the shift reset to serial data output (Q7S) propagation delays and the Fig. 9. shift reset to shift clock (SHCP) recovery time

8-bit shift register with output register



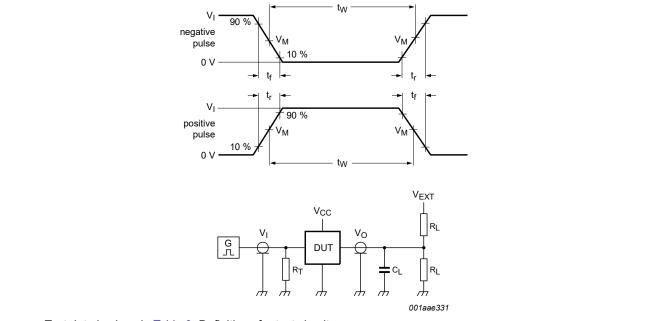
Measurement points are given in <u>Table 8</u>.

 V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

Fig. 10. The storage reset (STR) pulse width, the storage reset to parallel data output (Qn) propagation delays and the storage reset to storage clock (STCP) recovery time

Table 8. Measurement points

Supply voltage	Input	Output
V _{CC}	V _M	V _M
V _{CC} < 2.7 V	0.5 x V _{CC}	0.5 x V _{CC}
V _{CC} ≥ 2.7 V	1.5 V	1.5 V



Test data is given in $\underline{\text{Table 9}}$. Definitions for test circuit:

R_I = Load resistance.

C_L = Load capacitance including jig and probe capacitance.

 R_T = Termination resistance should be equal to output impedance Z_0 of the pulse generator.

 V_{EXT} = External voltage for measuring switching times.

Fig. 11. Test circuit for measuring switching times

Table 9. Test data

Supply voltage	voltage Input		Load		V _{EXT}	V _{EXT}		
	VI	t _r , t _f	CL	R _L	t _{PLH} , t _{PHL}	t _{PLZ} , t _{PZL}	t _{PHZ} , t _{PZH}	
1.2 V	V _{CC}	≤ 2 ns	30 pF	1 kΩ	open	2 x V _{CC}	GND	
1.65 V to 1.95 V	V _{CC}	≤ 2 ns	30 pF	1 kΩ	open	2 x V _{CC}	GND	
2.3 V to 2.7 V	V _{CC}	≤ 2 ns	30 pF	500 Ω	open	2 x V _{CC}	GND	
2.7 V	2.7 V	≤ 2.5 ns	50 pF	500 Ω	open	2 x V _{CC}	GND	
3.0 V to 3.6 V	2.7 V	≤ 2.5 ns	50 pF	500 Ω	open	2 x V _{CC}	GND	

8-bit shift register with output register

12. Package outline

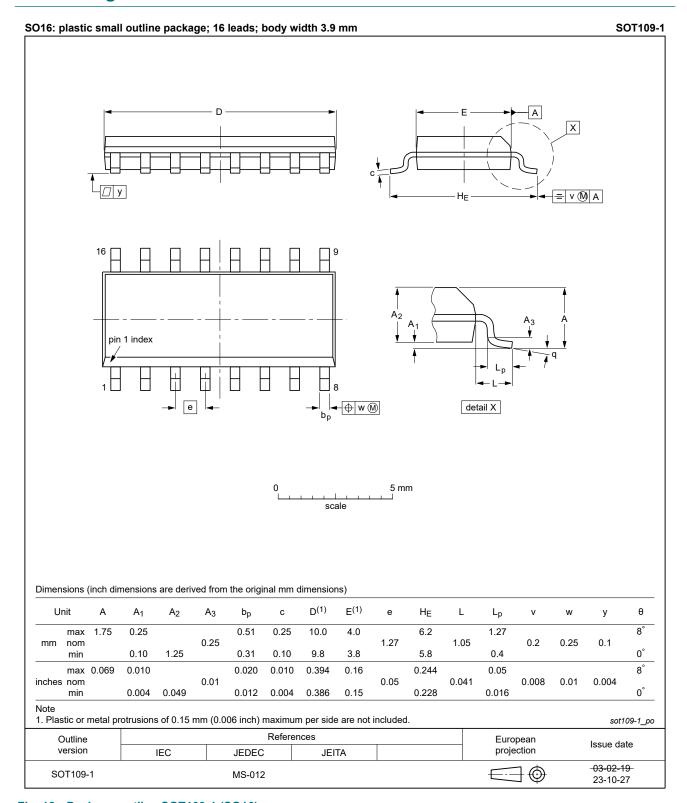


Fig. 12. Package outline SOT109-1 (SO16)

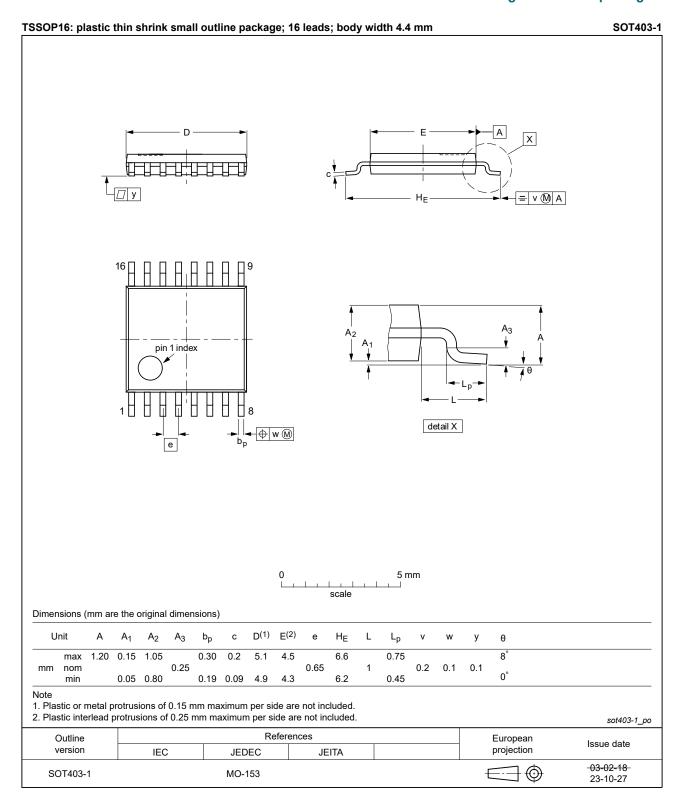


Fig. 13. Package outline SOT403-1 (TSSOP16)

8-bit shift register with output register

DHVQFN16: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 16 terminals; body 2.5 x 3.5 x 0.85 mm SOT763-1

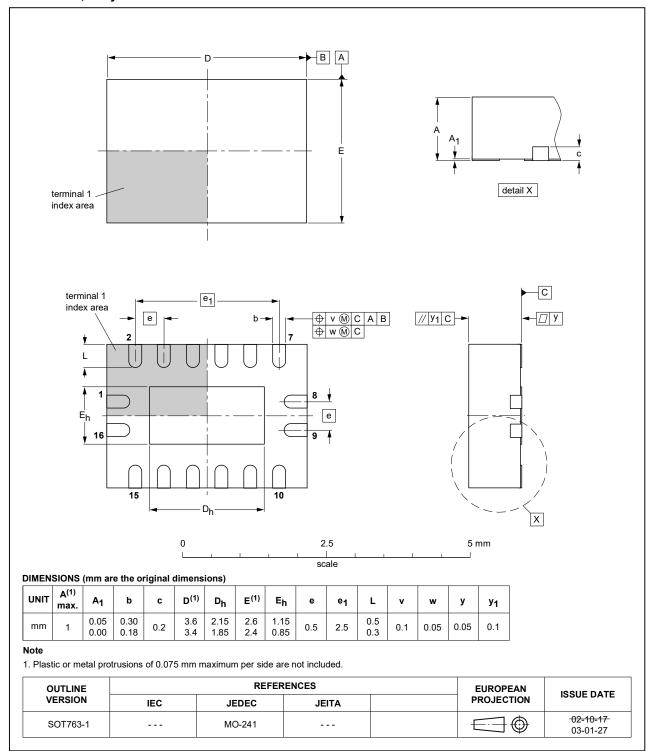


Fig. 14. Package outline SOT763-1 (DHVQFN16)

8-bit shift register with output register

DHXQFN16: plastic, leadless dual in-line compatible thermal enhanced extreme thin quad flat package; no leads; 16 terminals; 0.4 mm pitch; body 2 mm x 2.4 mm x 0.48 mm

SOT8016-1

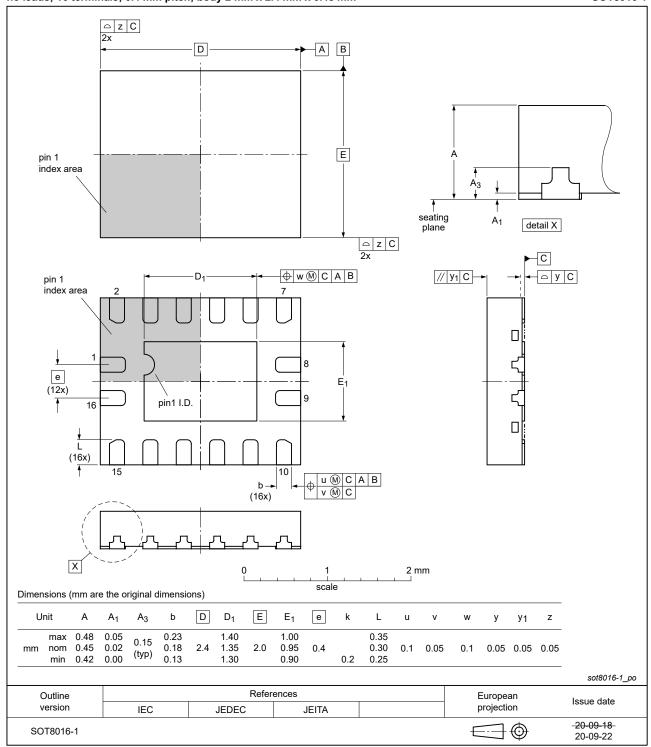


Fig. 15. Package outline SOT8016-1 (DHXQFN16)

8-bit shift register with output register

13. Abbreviations

Table 10. Abbreviations

Acronym	Description
CDM	Charged Device Model
CMOS	Complementary Metal Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
TTL	Transistor-Transistor Logic

14. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74LVC594A v.7	20250509	Product data sheet	-	74LVC594A v.6
Modifications:	Type number	er 74LVC594ABZ (SOT801	6-1/DHXQFN16)	added.
74LVC594A v.6	20240222	Product data sheet	-	74LVC594A v.5
Modifications:	• Fig. 12, Fig. and MO-153	•	P package outlin	e drawings to JEDEC MS-012
74LVC594A v.5	20230824	Product data sheet	-	74LVC594A v.4
Modifications:	Section 2: E	SD specification updated a	according to the la	atest JEDEC standard.
74LVC594A v.4	20200903	Product data sheet	-	74LVC594A v.3
Modifications:		nd <u>Section 2</u> updated. rating values for P _{tot} total p	ower dissipation ເ	updated.
74LVC594A v.3	20170720	Product data sheet	-	74LVC594A v.2
Modifications:	guidelines o Legal texts I	of this data sheet has beer if Nexperia. have been adapted to the r le note added for cascadin	new company nan	
74LVC594A v.2	20131021	Product data sheet	-	74LVC594A v.1
Modifications:	guidelines o	of this data sheet has been f NXP Semiconductors. have been adapted to the r	J	omply with the new identity ne where appropriate.
74LVC594A v.1	20070524	Product data sheet	-	-

8-bit shift register with output register

15. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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8-bit shift register with output register

Contents

1. General description	1
2. Features and benefits	1
3. Applications	1
4. Ordering information	2
5. Functional diagram	2
6. Pinning information	4
6.1. Pinning	4
6.2. Pin description	5
7. Functional description	5
8. Limiting values	5
Limiting values Recommended operating conditions	
_	6
9. Recommended operating conditions	6
9. Recommended operating conditions 10. Static characteristics	6 6
9. Recommended operating conditions 10. Static characteristics 11. Dynamic characteristics	67
 Recommended operating conditions Static characteristics Dynamic characteristics Waveforms and test circuit 	66710
9. Recommended operating conditions	671014

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